

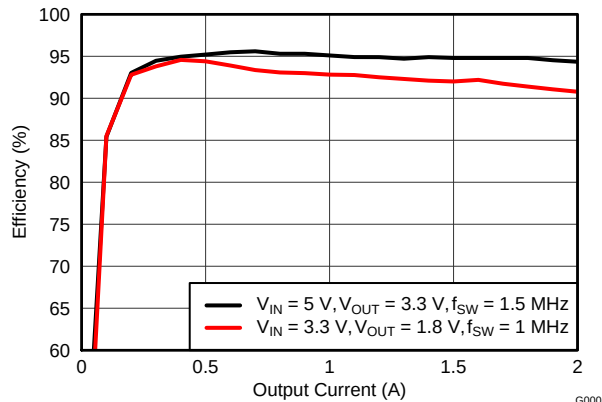
具有 2.95V-6V 输入，采用四方扁平无引线 (QFN) 封装的®电源模块

1 特性

- 完整的集成式电源解决方案可实现小尺寸和扁平设计
- 9mm x 11mm x 2.8mm 封装
 - 与 LMZ30604 & LMZ30606 引脚兼容
- 效率高达 96%
- 宽输出电压调节范围
0.8V 至 3.6V，基准精度为 $\pm 1\%$
- 可调开关频率
(500kHz 至 2MHz)
- 与外部时钟同步
- 可调节慢启动
- 输出电压排序/跟踪
- 电源正常输出
- 可编程欠压闭锁 (UVLO)
- 输出过流保护
- 过热保护
- 运行温度范围: -40°C 至 85°C
- 增强的散热性能: 12°C/W
- 符合 EN55022 B 类辐射标准
 - 集成屏蔽电感器

2 应用范围

- 宽带和通信基础设施
- 自动化测试和医疗设备
- 紧凑型 PCI/PCI 快速接口/PXI 快速接口
- DSP 和 FPGA 负载点应用
- 高密度分布式电源系统



3 说明

LMZ30602 SIMPLE SWITCHER® 电源模块是一款易于使用的集成式电源解决方案，此方案在低厚度 QFN 封装内组合了一个带功率 MOSFET 的 2A DC/DC 转换器、一个屏蔽电感器以及无源器件。这个整体电源解决方案仅需 3 个外部元件，并免除了环路补偿和磁性元件选择过程。

9×11×2.8mm QFN 封装能轻松焊接到印制电路板上，并且可实现效率高于 90% 的紧凑型负载点设计且具有结至环境的热阻仅为 12°C/W 的出色功率耗散。在环境温度为 85°C 且无气流的情况下，该器件可提供 2A 的满载额定输出电流。

LMZ30602 提供了分离式负载点设计的灵活性和功能集，是为高性能 DSP 和 FPGA 供电的理想选择。先进的封装技术可提供一个与标准 QFN 贴装和测试技术兼容的耐用且可靠的电源解决方案。

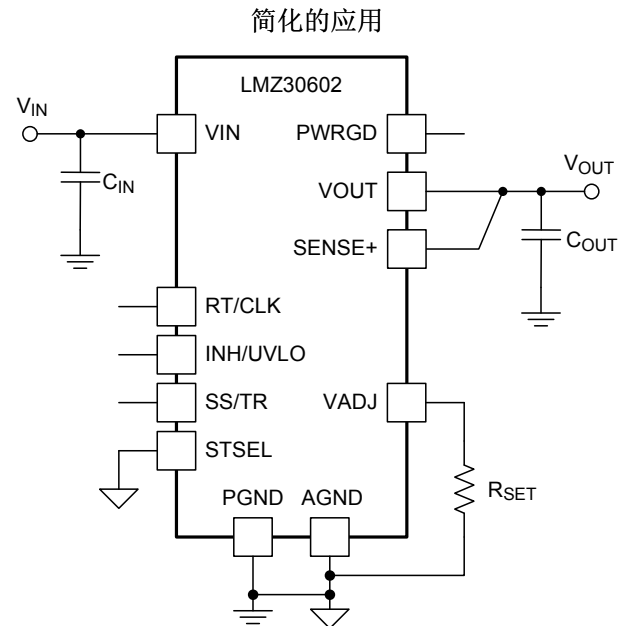


Table 1. ORDERING INFORMATION

For the most current package and ordering information, see the Package Option Addendum at the end of this datasheet, or see the TI website at www.ti.com.

4 Specifications

4.1 ABSOLUTE MAXIMUM RATINGS

over operating temperature range (unless otherwise noted)⁽¹⁾

		VALUE		UNIT
		MIN	MAX	
Input Voltage	VIN, PWRGD	−0.3	7	V
	INH/UVLO, RT/CLK	−0.3	3.3	V
	SS/TR, STSEL, VADJ	−0.3	3	V
	SENSE+ VADJ rating must also be met	−0.3	VOUT	V
Output Voltage	PH	−0.6	7	V
	PH 10ns Transient	−2	7	V
	VOUT	−0.6	VIN	V
V _{DIFF} (GND to exposed thermal pad)		−0.2	0.2	V
Source Current	RT/CLK, INH/UVLO		±100	μA
	PH		Current Limit	A
Sink Current	PH		Current Limit	A
	SS/TR		±100	μA
	PWRGD		10	mA
Operating Junction Temperature		−40	125 ⁽²⁾	°C
Storage Temperature		−65	150	°C
Peak Reflow Case Temperature ⁽³⁾			240	°C
Maximum Number of Reflows Allowed ⁽³⁾			1	
Mechanical Shock	Mil-STD-883D, Method 2002.3, 1 msec, 1/2 sine, mounted		1500	G
Mechanical Vibration	Mil-STD-883D, Method 2007.2, 20-2000Hz		20	

- (1) Stresses beyond those listed under absolute maximum ratings may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under recommended operating conditions is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.
- (2) See the temperature derating curves in the Typical Characteristics section for thermal information.
- (3) For soldering specifications, refer to the [Soldering Requirements for BQFN Packages](#) application note.

4.2 THERMAL INFORMATION

THERMAL METRIC ⁽¹⁾		LMZ30602	UNIT
		RKG39	
		39 PINS	
θ _{JA}	Junction-to-ambient thermal resistance ⁽²⁾	12	°C/W
ψ _{JT}	Junction-to-top characterization parameter ⁽³⁾	2.2	
ψ _{JB}	Junction-to-board characterization parameter ⁽⁴⁾	9.7	

- (1) For more information about traditional and new thermal metrics, see the IC Package Thermal Metrics application report, [SPRA953](#).
- (2) The junction-to-ambient thermal resistance, θ_{JA}, applies to devices soldered directly to a 100 mm x 100 mm double-sided PCB with 1 oz. copper and natural convection cooling. Additional airflow reduces θ_{JA}.
- (3) The junction-to-top characterization parameter, ψ_{JT}, estimates the junction temperature, T_J, of a device in a real system, using a procedure described in JESD51-2A (sections 6 and 7). T_J = ψ_{JT} * P_{dis} + T_T; where P_{dis} is the power dissipated in the device and T_T is the temperature of the top of the device.
- (4) The junction-to-board characterization parameter, ψ_{JB}, estimates the junction temperature, T_J, of a device in a real system, using a procedure described in JESD51-2A (sections 6 and 7). T_J = ψ_{JB} * P_{dis} + T_B; where P_{dis} is the power dissipated in the device and T_B is the temperature of the board 1mm from the device.

4.3 ELECTRICAL CHARACTERISTICS

Over -40°C to 85°C free-air temperature, $V_{IN} = 3.3\text{ V}$, $V_{OUT} = 1.8\text{ V}$, $I_{OUT} = 2\text{ A}$, $C_{IN1} = 47\text{ }\mu\text{F}$ ceramic, $C_{IN2} = 220\text{ }\mu\text{F}$ poly-tantalum, $C_{OUT1} = 47\text{ }\mu\text{F}$ ceramic, $C_{OUT2} = 100\text{ }\mu\text{F}$ poly-tantalum (unless otherwise noted)

PARAMETER		TEST CONDITIONS		MIN	TYP	MAX	UNIT
I _{OUT}	Output current	T _A = 85°C, natural convection		0		2	A
V _{IN}	Input voltage range	Over I _{OUT} range		2.95 ⁽¹⁾		6	V
UVLO	VIN Undervoltage lockout	VIN = increasing			3.05	3.135	V
		VIN = decreasing		2.5	2.75		
V _{OUT(adj)}	Output voltage adjust range	Over I _{OUT} range		0.8		3.6	V
V _{OUT}	Set-point voltage tolerance	T _A = 25°C, I _{OUT} = 0A				±1.0% ⁽²⁾	
	Temperature variation	-40°C ≤ T _A ≤ +85°C, I _{OUT} = 0A			±0.3%		
	Line regulation	Over VIN range, T _A = 25°C, I _{OUT} = 0A			±0.1%		
	Load regulation	Over I _{OUT} range, T _A = 25°C			±0.1%		
	Total output voltage variation	Includes set-point, line, load, and temperature variation				±1.5% ⁽²⁾	
η	Efficiency	VIN = 5 V I _O = 1 A	V _{OUT} = 3.3V, f _{SW} = 1.5 MHz		95%		
			V _{OUT} = 2.5V, f _{SW} = 1.5 MHz		93%		
			V _{OUT} = 1.8V, f _{SW} = 1 MHz		92%		
			V _{OUT} = 1.5V, f _{SW} = 1 MHz		91%		
			V _{OUT} = 1.2V, f _{SW} =750 kHz		90%		
			V _{OUT} = 1.0V, f _{SW} = 650 kHz		88%		
			V _{OUT} = 0.8V, f _{SW} = 650 kHz		87%		
		VIN = 3.3V I _O = 1 A	V _{OUT} = 1.8V, f _{SW} = 1 MHz		93%		
			V _{OUT} = 1.5V, f _{SW} = 1 MHz		92%		
			V _{OUT} = 1.2V, f _{SW} = 750 kHz		91%		
			V _{OUT} = 1.0V, f _{SW} = 650 kHz		89%		
			V _{OUT} = 0.8V, f _{SW} = 650 kHz		87%		
Output voltage ripple		20 MHz bandwidth			9		mV _{PP}
I _{LIM}	Overcurrent threshold				3.5		A
Transient response		1.0 A/μs load step from 0.5A to 1.5A	Recovery time		80		μs
			V _{OUT} over/undershoot		45		mV
V _{INH-H}	Inhibit Control	Inhibit High Voltage			1.25	Open ⁽³⁾	V
V _{INH-L}		Inhibit Low Voltage		-0.3		1.0	
I _{I(stby)}	Input standby current	INH pin to AGND			70	100	μA
Power Good	PWRGD Thresholds	V _{OUT} rising	Good		93%		
			Fault		107%		
		V _{OUT} falling	Fault		91%		
			Good		105%		
	PWRGD Low Voltage		I(PWRGD) = 0.33 mA			0.3	
f _{SW}	Switching frequency	Over VIN and I _{OUT} ranges, RT/CLK pin OPEN		400	500	600	kHz
f _{CLK}	Synchronization frequency	CLK Control		500		2000	kHz
V _{CLK-H}	CLK High-Level Threshold			2.2		3.3	V
V _{CLK-L}	CLK Low-Level Threshold			-0.3		0.4	V
CLK_PW	CLK Pulse Width			75 ⁽⁴⁾			ns
Thermal Shutdown				Thermal shutdown			175
		Thermal shutdown hysteresis			15		°C

- (1) The minimum V_{IN} depends on V_{OUT} and the switching frequency. Please refer to [Table 9](#) for operating limits.
- (2) The stated limit of the set-point voltage tolerance includes the tolerance of both the internal voltage reference and the internal adjustment resistor. The overall output voltage tolerance will be affected by the tolerance of the external R_{SET} resistor.
- (3) This control pin has an internal pullup. Do not place an external pull-up resistor on this pin. If this pin is left open circuit, the device operates when input power is applied. A small low-leakage MOSFET is recommended for control. See the application section for further guidance.
- (4) The maximum synchronization clock pulse width is dependant on V_{IN} , V_{OUT} , and the synchronization frequency. See the [Synchronization \(CLK\)](#) section for more information.

LMZ30602

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ELECTRICAL CHARACTERISTICS (continued)

Over -40°C to 85°C free-air temperature, $V_{IN} = 3.3\text{ V}$, $V_{OUT} = 1.8\text{ V}$, $I_{OUT} = 2\text{ A}$,
 $C_{IN1} = 47\text{ }\mu\text{F}$ ceramic, $C_{IN2} = 220\text{ }\mu\text{F}$ poly-tantalum, $C_{OUT1} = 47\text{ }\mu\text{F}$ ceramic, $C_{OUT2} = 100\text{ }\mu\text{F}$ poly-tantalum (unless otherwise noted)

PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
C_{IN} External input capacitance	Ceramic	47 ⁽⁵⁾			μF
	Non-ceramic		220 ⁽⁵⁾		
C_{OUT} External output capacitance	Ceramic	47 ⁽⁶⁾	150	650 ⁽⁷⁾	μF
	Non-ceramic		100 ⁽⁶⁾	1000 ⁽⁷⁾	
	Equivalent series resistance (ESR)			25	m Ω

- (5) A minimum of 47 μF of ceramic capacitance is required across the input for proper operation. Locate the capacitor close to the device. An additional 220 μF of bulk capacitance is recommended. See [Table 7](#) for more details.
- (6) The amount of required output capacitance varies depending on the output voltage (see [Table 5](#)). The amount of required capacitance must include at least 47 μF of ceramic capacitance. Locate the capacitance close to the device. Adding additional capacitance close to the load improves the response of the regulator to load transients. See [Table 5](#) and [Table 7](#) for more details.
- (7) When using both ceramic and non-ceramic output capacitance, the combined maximum must not exceed 1200 μF .

4.4 PACKAGE SPECIFICATIONS

LMZ30602		UNIT
Weight		0.85 grams
Flammability	Meets UL 94 V-O	
MTBF Calculated reliability	Per Bellcore TR-332, 50% stress, $T_A = 40^\circ\text{C}$, ground benign	38.5 Mhrs

5 DEVICE INFORMATION

FUNCTIONAL BLOCK DIAGRAM

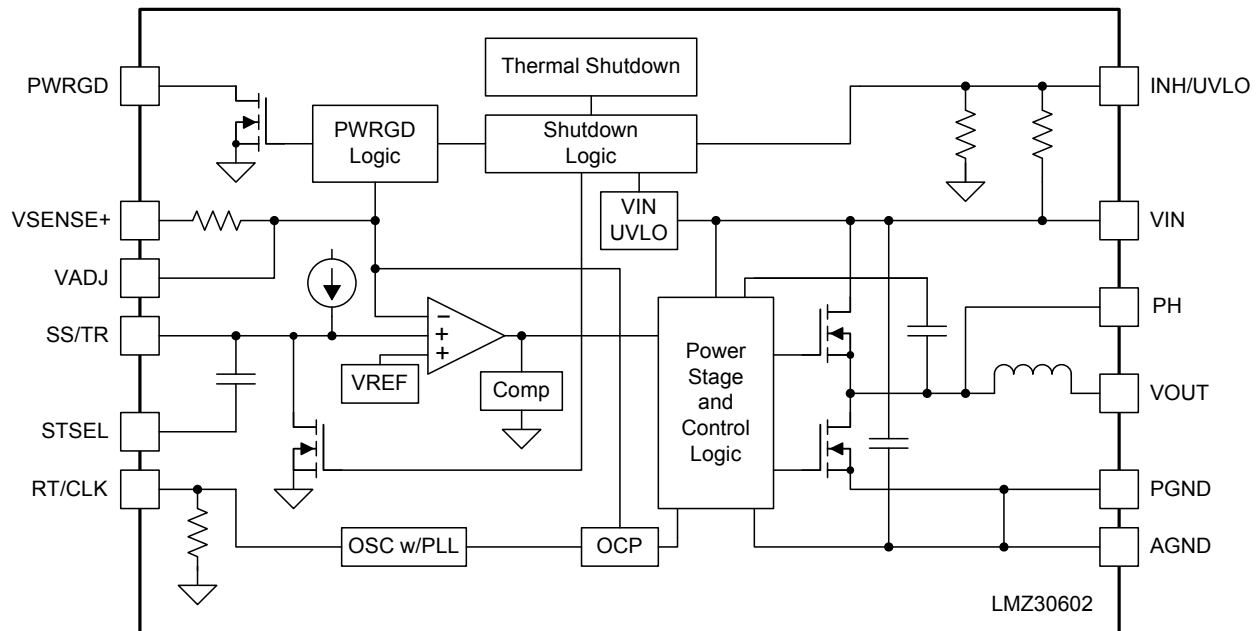
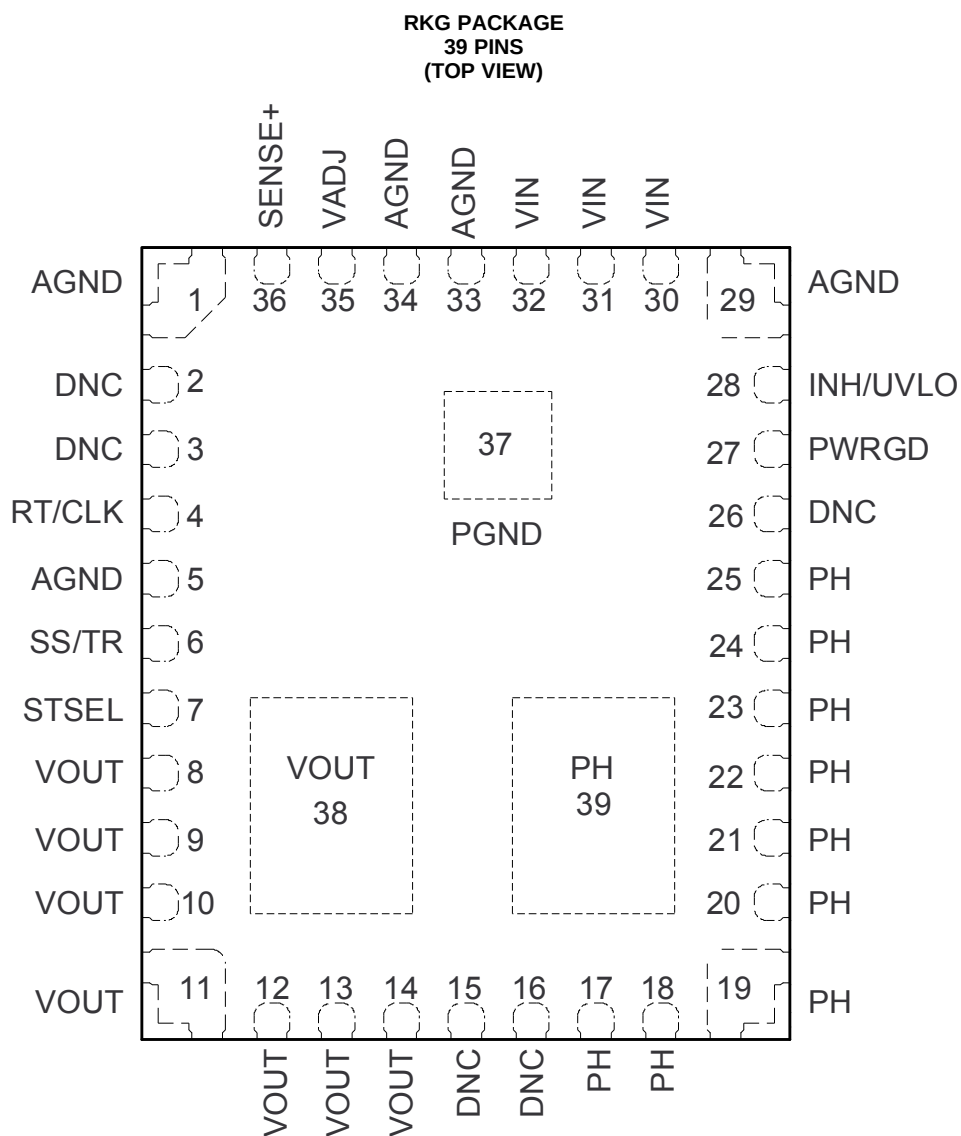


Table 2. PIN DESCRIPTIONS

TERMINAL		DESCRIPTION
NAME	NO.	
AGND	1	Zero VDC reference for the analog control circuitry. These pins should be connected directly to the PCB analog ground plane. Not all pins are connected together internally. All pins must be connected together externally with a copper plane or pour directly under the module. Connect the AGND copper area to the PGND copper area at a single point; directly at the pin 37 PowerPAD using multiple vias. See the recommended layout in Figure 36 .
	5	
	29	
	33	
	34	
PowerPAD (PGND)	37	This pad provides both an electrical and thermal connection to the PCB. This pad should be connected directly to the PCB power ground plane using multiple vias for good electrical and thermal performance. The same vias should also be used to connect to the PCB analog ground plane. See the recommended layout in Figure 36 .
DNC	2	Do Not Connect. Do not connect these pins to AGND, to another DNC pin, or to any other voltage. These pins are connected to internal circuitry. Each pin must be soldered to an isolated pad.
	3	
	15	
	16	
	26	
INH/UVLO	28	Inhibit and UVLO adjust pin. Use an open drain or open collector output logic to control the INH function. A resistor between this pin and AGND adjusts the UVLO voltage.
PH	17	Phase switch node. These pins should be connected by a small copper island under the device for thermal relief. Do not connect any external component to this pin or tie it to a pin of another function.
	18	
	19	
	20	
	21	
	22	
	23	
	24	
	25	
	39	
PWRGD	27	Power good fault pin. Asserts low if the output voltage is out of tolerance. A pull-up resistor is required.
RT/CLK	4	This pin automatically selects between RT mode and CLK mode. An external timing resistor adjusts the switching frequency of the device. In CLK mode, the device synchronizes to an external clock.
SENSE+	36	Remote sense connection. Connect this pin to VOUT at the load for improved regulation. This pin must be connected to VOUT at the load, or at the module pins.
SS/TR	6	Slow-start and tracking pin. Connecting an external capacitor to this pin adjusts the output voltage rise time. A voltage applied to this pin allows for tracking and sequencing control.
STSEL	7	Slow-start or track feature select. Connect this pin to AGND to enable the internal SS capacitor with a SS interval of approximately 1.1 ms. Leave this pin open to enable the TR feature.
VADJ	35	Connecting a resistor between this pin and AGND sets the output voltage above the 0.8V default voltage.
VIN	30	The positive input voltage power pins, which are referenced to PGND. Connect external input capacitance between these pins and the PGND plane, close to the device.
	31	
	32	
VOUT	8	Output voltage. Connect output capacitors between these pins and the PGND plane, close to the device.
	9	
	10	
	11	
	12	
	13	
	14	
	38	



6 TYPICAL CHARACTERISTICS (VIN = 5 V) ⁽¹⁾ ⁽²⁾

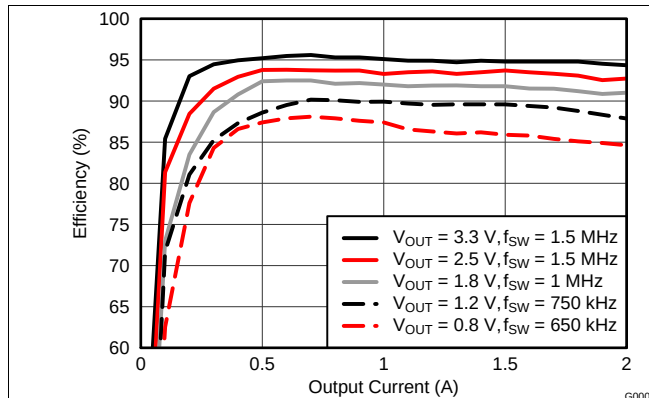


Figure 1. Efficiency vs. Output Current

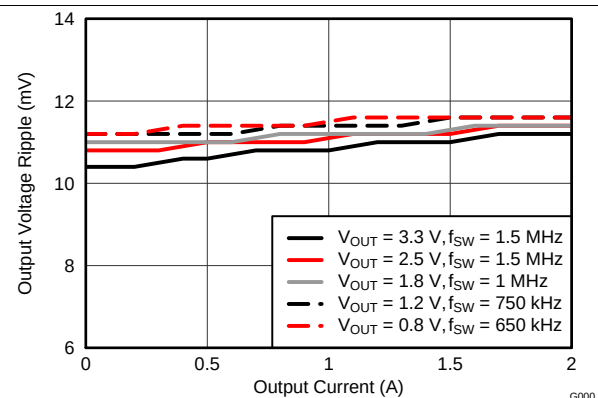


Figure 2. Voltage Ripple vs. Output Current

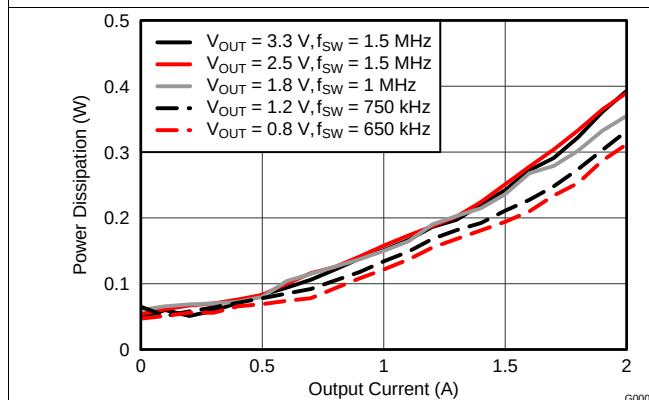


Figure 3. Power Dissipation vs. Output Current

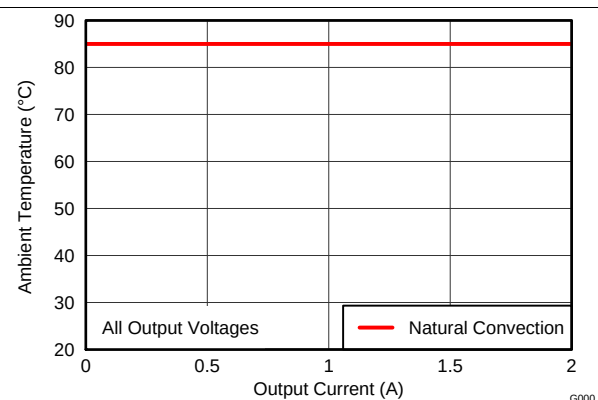


Figure 4. Safe Operating Area

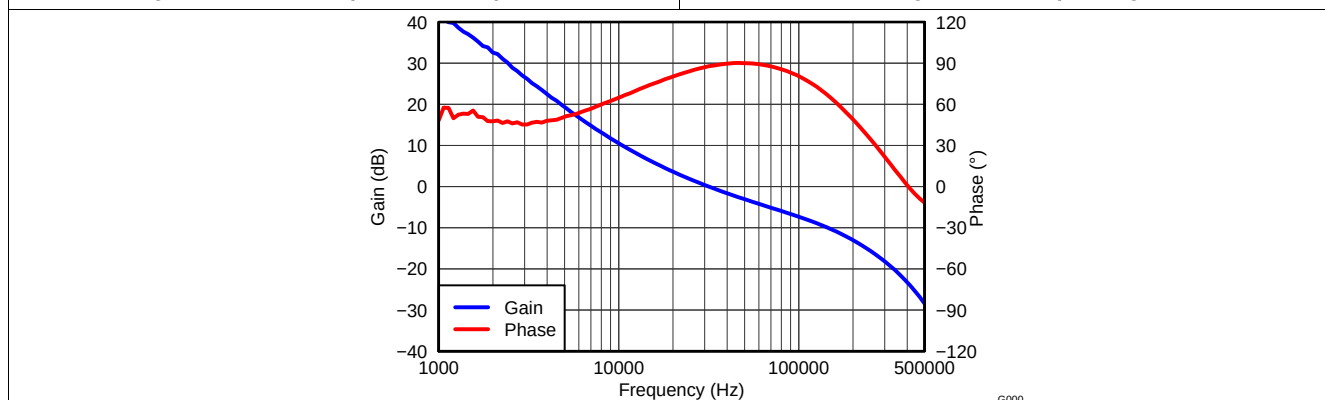


Figure 5. $V_{OUT} = 1.8$ V, $I_{OUT} = 2$ A, $C_{OUT1} = 47$ μ F ceramic, $C_{OUT2} = 100$ μ F POSCAP, $f_{SW} = 1$ MHz

- (1) The electrical characteristic data has been developed from actual products tested at 25°C. This data is considered typical for the converter. Applies to [Figure 1](#), [Figure 2](#), and [Figure 3](#).
- (2) The temperature derating curves represent the conditions at which internal components are at or below the manufacturer's maximum operating temperatures. Derating limits apply to devices soldered directly to a 100 mm × 100 mm double-sided PCB with 1 oz. copper. Applies to [Figure 4](#).

7 TYPICAL CHARACTERISTICS (VIN = 3.3 V) ⁽¹⁾ ⁽²⁾

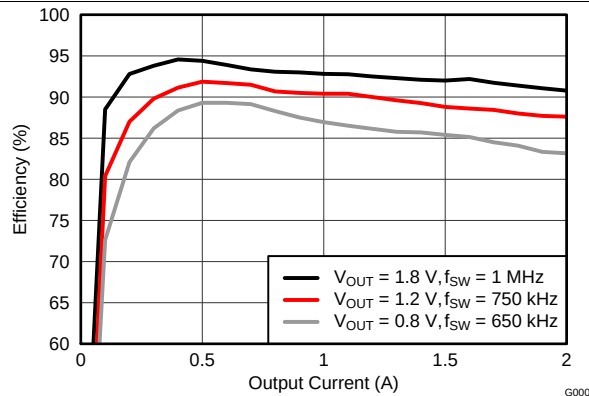


Figure 6. Efficiency vs. Output Current

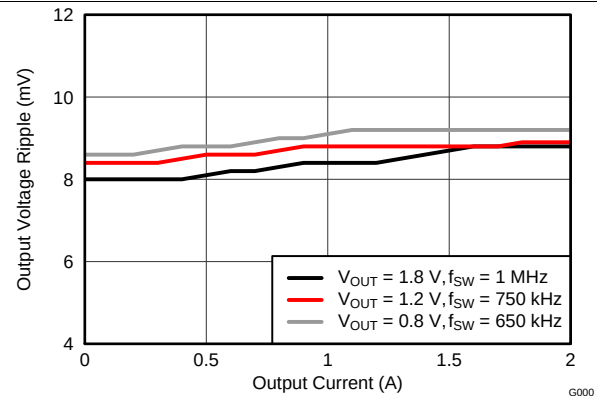


Figure 7. Voltage Ripple vs. Output Current

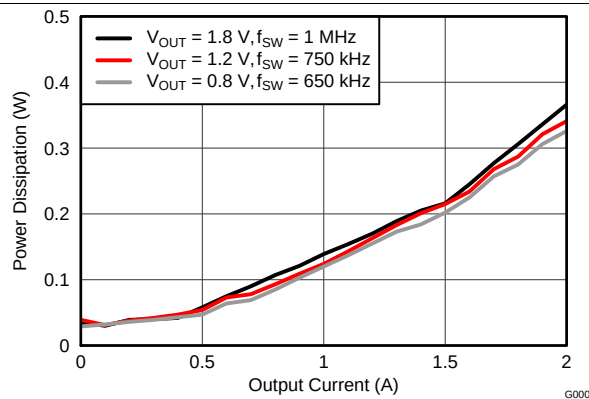


Figure 8. Power Dissipation vs. Output Current

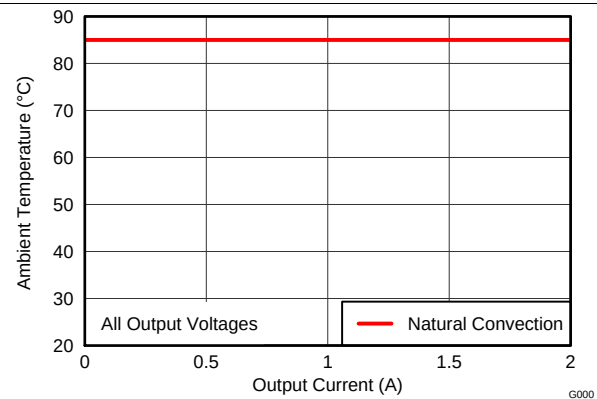


Figure 9. Safe Operating Area

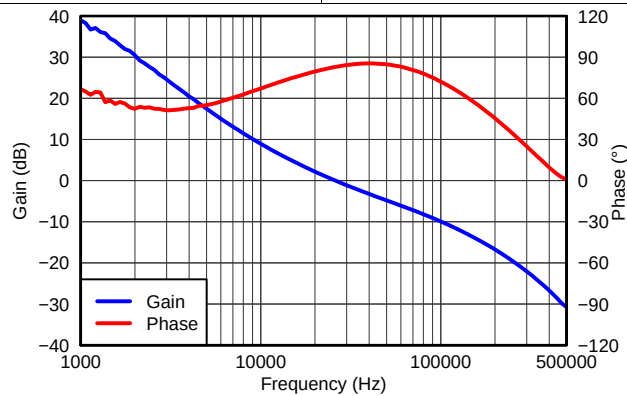


Figure 10. VOUT = 1.8 V, IOUT = 2 A, COUT1 = 47 μ F ceramic, COUT2 = 100 μ F POSCAP, fSW = 1 MHz

- (1) The electrical characteristic data has been developed from actual products tested at 25°C. This data is considered typical for the converter. Applies to [Figure 6](#), [Figure 7](#), and [Figure 8](#).
- (2) The temperature derating curves represent the conditions at which internal components are at or below the manufacturer's maximum operating temperatures. Derating limits apply to devices soldered directly to a 100 mm $\times$ 100 mm double-sided PCB with 1 oz. copper. Applies to [Figure 9](#).

8 APPLICATION INFORMATION

8.1 ADJUSTING THE OUTPUT VOLTAGE

The VADJ control sets the output voltage of the LMZ30602. The output voltage adjustment range is from 0.8V to 3.6V. The adjustment method requires the addition of R_{SET} , which sets the output voltage, the connection of SENSE+ to VOUT, and in some cases R_{RT} which sets the switching frequency. The R_{SET} resistor must be connected directly between the VADJ (pin 35) and AGND (pin 33 & 34). The SENSE+ pin (pin 36) must be connected to VOUT either at the load for improved regulation or at VOUT of the module. The R_{RT} resistor must be connected directly between the RT/CLK (pin 4) and AGND (pins 33 & 34).

Table 3 gives the standard external R_{SET} resistor for a number of common bus voltages, along with the recommended R_{RT} resistor for that output voltage.

Table 3. Standard R_{SET} Resistor Values for Common Output Voltages

RESISTORS	OUTPUT VOLTAGE V_{OUT} (V)					
	0.8	1.2	1.5	1.8	2.5	3.3
R_{SET} (k Ω)	open	2.87	1.65	1.15	0.673	0.459
R_{RT} (k Ω)	1200	715	348	348	174	174

For other output voltages, the value of the required resistor can either be calculated using the following formula, or simply selected from the range of values given in Table 4.

$$R_{SET} = \frac{1.43}{\left(\left(\frac{V_{OUT}}{0.803}\right) - 1\right)} \text{ (k}\Omega\text{)} \quad (1)$$

Table 4. Standard R_{SET} Resistor Values

V_{OUT} (V)	R_{SET} (k Ω)	R_{RT} (k Ω)	f_{SW} (kHz)	V_{OUT} (V)	R_{SET} (k Ω)	R_{RT} (k Ω)	f_{SW} (kHz)
0.8	open	1200	650	2.3	0.768	174	1500
0.9	11.8	1200	650	2.4	0.715	174	1500
1.0	5.83	1200	650	2.5	0.673	174	1500
1.1	3.83	1200	650	2.6	0.634	174	1500
1.2	2.87	715	750	2.7	0.604	174	1500
1.3	2.32	715	750	2.8	0.576	174	1500
1.4	1.91	715	750	2.9	0.549	174	1500
1.5	1.65	348	1000	3.0	0.523	174	1500
1.6	1.43	348	1000	3.1	0.499	174	1500
1.7	1.27	348	1000	3.2	0.475	174	1500
1.8	1.15	348	1000	3.3	0.459	174	1500
1.9	1.05	348	1000	3.4	0.442	174	1500
2.0	0.953	174	1500	3.5	0.422	174	1500
2.1	0.845	174	1500	3.6	0.412	174	1500
2.2	0.825	174	1500				

8.2 CAPACITOR RECOMMENDATIONS FOR THE LMZ30602 POWER SUPPLY

8.2.1 Capacitor Technologies

8.2.1.1 Electrolytic, Polymer-Electrolytic Capacitors

When using electrolytic capacitors, high-quality, computer-grade electrolytic capacitors are recommended. Polymer-electrolytic type capacitors are recommended for applications where the ambient operating temperature is less than 0°C. The Sanyo OS-CON capacitor series is suggested due to the lower ESR, higher rated surge, power dissipation, ripple current capability, and small package size. Aluminum electrolytic capacitors provide adequate decoupling over the frequency range of 2 kHz to 150 kHz, and are suitable when ambient temperatures are above 0°C.

8.2.1.2 Ceramic Capacitors

The performance of aluminum electrolytic capacitors is less effective than ceramic capacitors above 150 kHz. Multilayer ceramic capacitors have a low ESR and a resonant frequency higher than the bandwidth of the regulator. They can be used to reduce the reflected ripple current at the input as well as improve the transient response of the output.

8.2.1.3 Tantalum, Polymer-Tantalum Capacitors

Polymer-tantalum type capacitors are recommended for applications where the ambient operating temperature is less than 0°C. The Sanyo POSCAP series and Kemet T530 capacitor series are recommended rather than many other tantalum types due to their lower ESR, higher rated surge, power dissipation, ripple current capability, and small package size. Tantalum capacitors that have no stated ESR or surge current rating are not recommended for power applications.

8.2.2 Input Capacitor

The LMZ30602 requires a minimum input capacitance of 47 μF of ceramic capacitance. An additional 220 μF polymer-tantalum capacitor is recommended for applications with transient load requirements. The combined ripple current rating of the input capacitors must be at least 1000 mArms. [Table 7](#) includes a preferred list of capacitors by vendor. For applications where the ambient operating temperature is less than 0°C, an additional 1 μF , X5R or X7R ceramic capacitor placed between VIN and AGND is recommended.

8.2.3 Output Capacitor

The required output capacitance is determined by the output voltage of the LMZ30602. See [Table 5](#) for the amount of required capacitance. The required output capacitance must include at least one 47 μF ceramic capacitor. For applications where the ambient operating temperature is less than 0°C, an additional 100 μF polymer-tantalum capacitor is recommended. When adding additional non-ceramic bulk capacitors, low-ESR devices like the ones recommended in [Table 7](#) are required. The required capacitance above the minimum is determined by actual transient deviation requirements. See [Table 6](#) for typical transient response values for several output voltage, input voltage and capacitance combinations. [Table 7](#) includes a preferred list of capacitors by vendor.

Table 5. Required Output Capacitance

V _{OUT} RANGE (V)		MINIMUM REQUIRED C _{OUT} (μF)
MIN	MAX	
0.8	< 1.8	147 ⁽¹⁾
1.8	< 3.3	100 ⁽²⁾
3.3	3.6	47 ⁽²⁾

(1) Minimum required must include at least 1 x 47 μF ceramic capacitor plus 1 x 100 μF polymer-tantalum capacitor.

(2) Minimum required must include at least 47 μF of ceramic capacitance.

Table 6. Output Voltage Transient Response

C_{IN1} = 1 x 47 µF CERAMIC, C_{IN2} = 220 µF POLYMER-TANTALUM, LOAD STEP = 1 A, 1 A/µs						
V_{OUT} (V)	V_{IN} (V)	C_{OUT1} Ceramic	C_{OUT2} BULK	VOLTAGE DEVIATION (mV)	PEAK-PEAK (mV)	RECOVERY TIME (µs)
0.8	3.3	47 µF	100 µF	30	55	70
		47 µF	330 µF	20	35	70
	5	47 µF	100 µF	30	50	65
		47 µF	330 µF	20	35	65
1.2	3.3	47 µF	100 µF	35	65	65
		47 µF	330 µF	25	50	80
	5	47 µF	100 µF	35	70	65
		47 µF	330 µF	25	45	75
1.8	3.3	47 µF	100 µF	45	80	70
		47 µF	330 µF	35	65	90
	5	47 µF	100 µF	40	65	70
		47 µF	330 µF	35	65	90
2.5	5	47 µF	100 µF	60	100	70
		2x 47 µF	-	75	140	75
3.3	5	47 µF	100 µF	70	130	80
		47 µF	-	90	180	90

Table 7. Recommended Input/Output Capacitors⁽¹⁾

VENDOR	SERIES	PART NUMBER	CAPACITOR CHARACTERISTICS		
			WORKING VOLTAGE (V)	CAPACITANCE (µF)	ESR ⁽²⁾ (mΩ)
Murata	X5R	GRM32ER61C476K	16	47	2
TDK	X5R	C3225X5R0J107M	6.3	100	2
Murata	X5R	GRM32ER60J107M	6.3	100	2
TDK	X5R	C3225X5R0J476K	6.3	47	2
Murata	X5R	GRM32ER60J476M	6.3	47	2
Sanyo	POSCAP	10TPE220ML	10	220	25
Kemet	T520	T520V107M010ASE025	10	100	25
Sanyo	POSCAP	6TPE100MPB	6.3	100	25
Sanyo	POSCAP	2R5TPE220M7	2.5	220	7
Kemet	T530	T530D227M006ATE006	6.3	220	6
Kemet	T530	T530D337M006ATE010	6.3	330	10
Sanyo	POSCAP	2TPF330M6	2.0	330	6
Sanyo	POSCAP	6TPE330MFL	6.3	330	15

(1) Capacitor Supplier Verification

Please verify availability of capacitors identified in this table.

RoHS, Lead-free and Material Details

Please consult capacitor suppliers regarding material composition, RoHS status, lead-free status, and manufacturing process requirements.

(2) Maximum ESR @ 100kHz, 25°C.

8.3 Transient Response

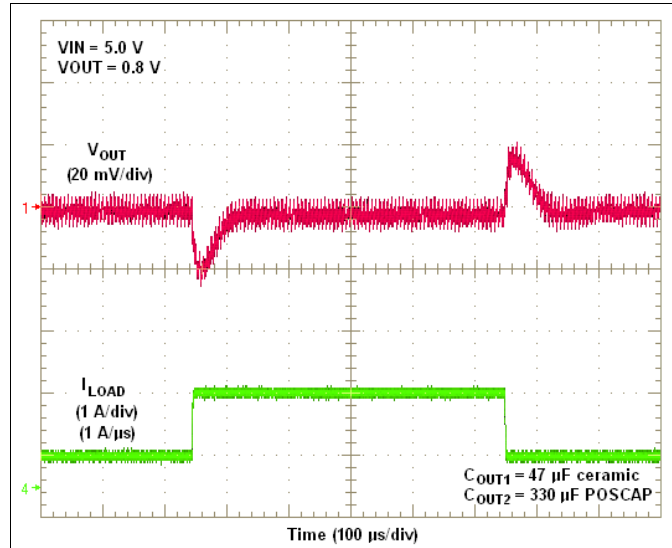


Figure 11. VIN = 5V, VOUT = 0.8V, 1A Load Step

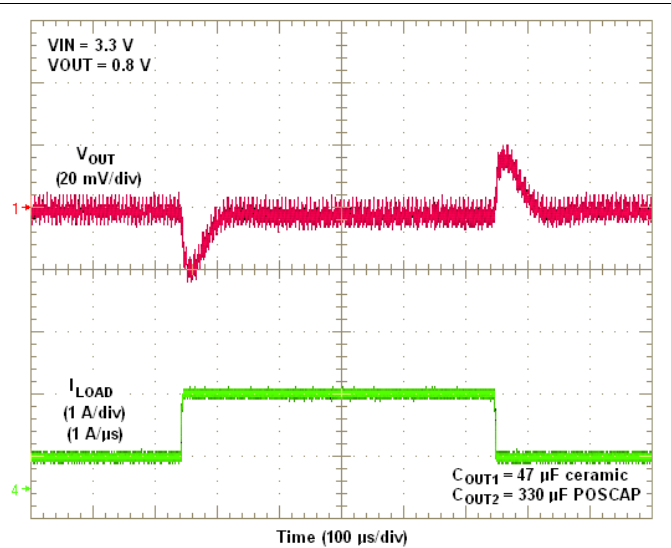


Figure 12. VIN = 3.3V, VOUT = 0.8V, 1A Load Step

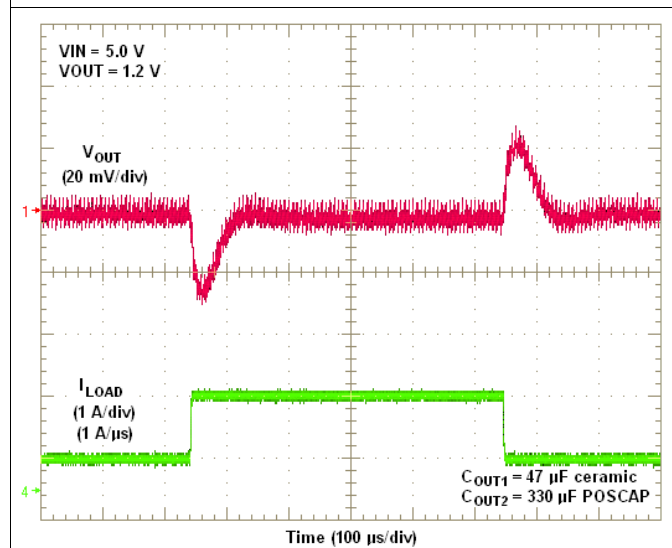


Figure 13. VIN = 5V, VOUT = 1.2V, 1A Load Step

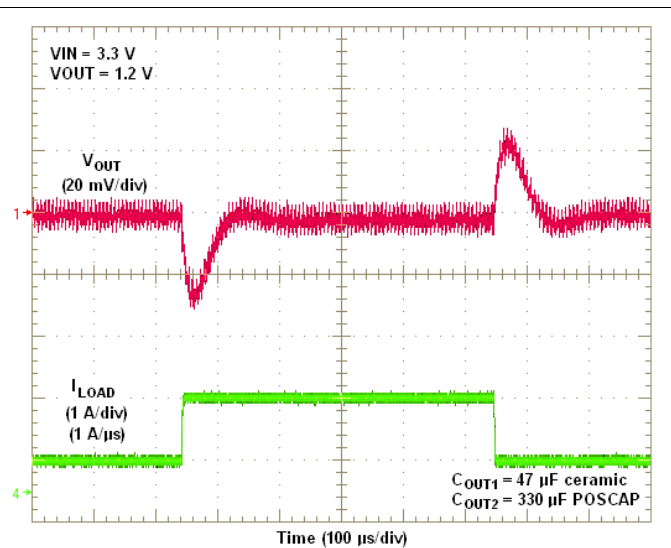
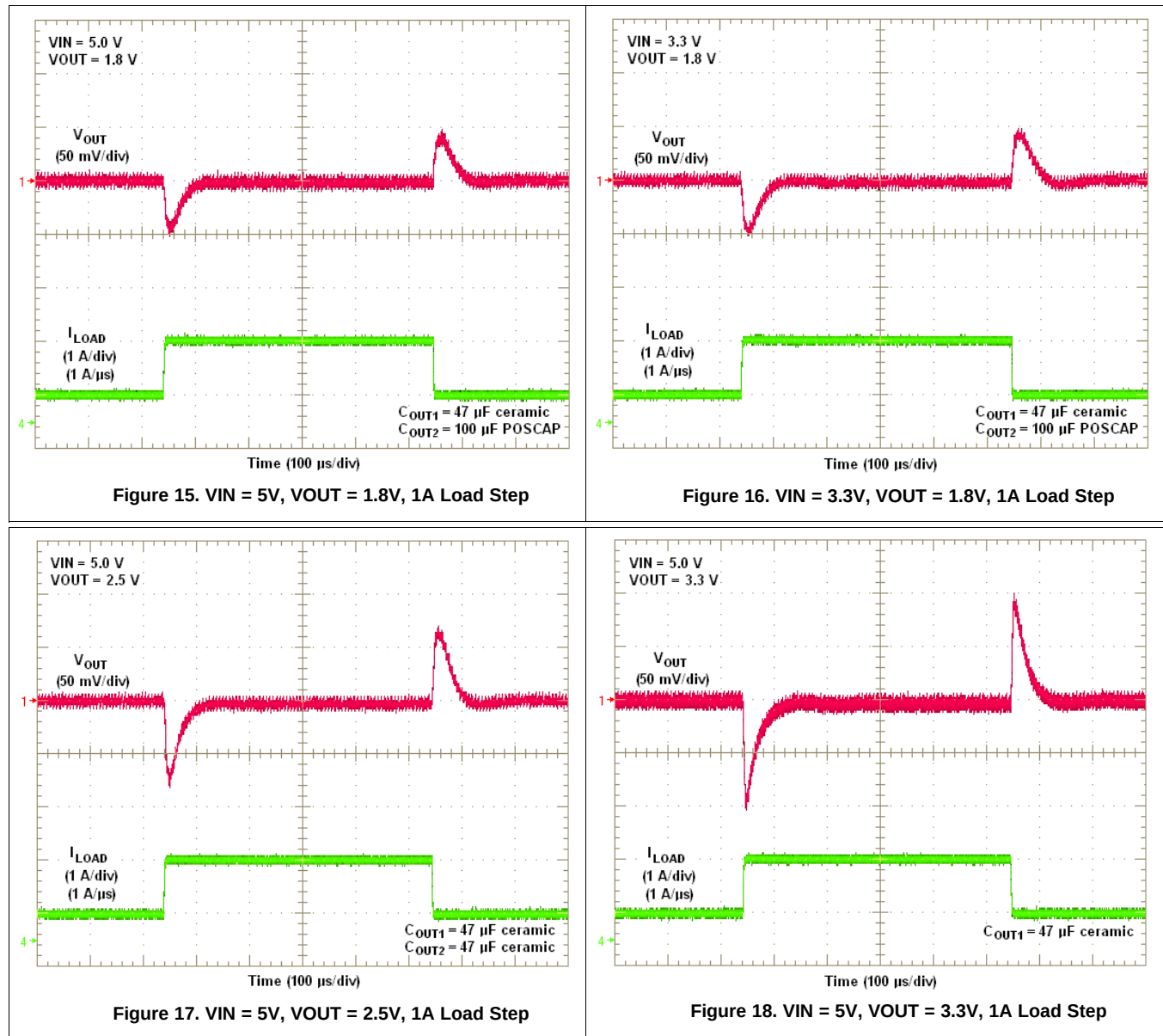


Figure 14. VIN = 3.3V, VOUT = 1.2V, 1A Load Step

Transient Response (continued)



8.4 Application Schematics

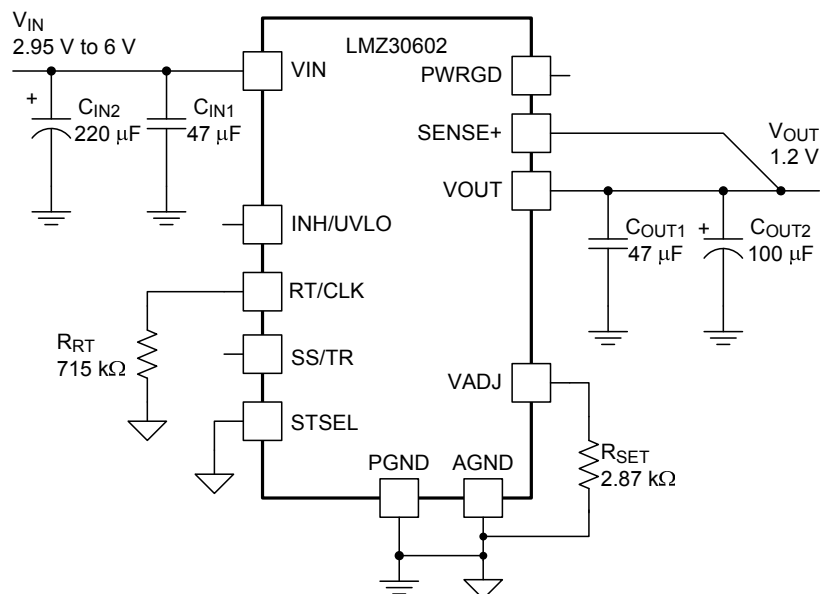


Figure 19. Typical Schematic
 $V_{IN} = 2.95 \text{ V to } 6.0 \text{ V}$, $V_{OUT} = 1.2 \text{ V}$

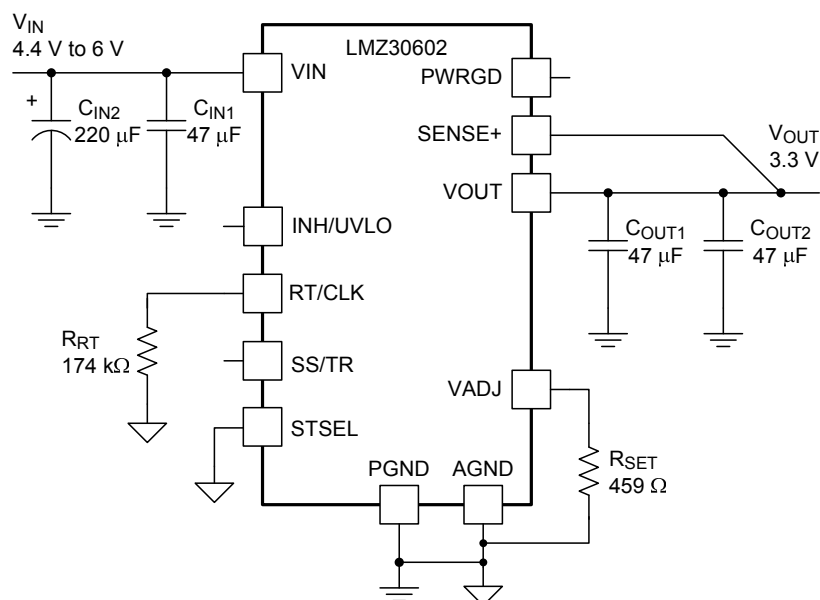


Figure 20. Typical Schematic
 $V_{IN} = 4.4 \text{ V to } 6.0 \text{ V}$, $V_{OUT} = 3.3 \text{ V}$

8.5 Power Good (PWRGD)

The PWRGD pin is an open drain output. Once the voltage on the SENSE+ pin is between 93% and 105% of the set voltage, the PWRGD pin pull-down is released and the pin floats. The recommended pull-up resistor value is between 10 k Ω and 100 k Ω to a voltage source that is 6 V or less. The PWRGD pin is in a defined state once VIN is greater than 1.2 V, but with reduced current sinking capability. The PWRGD pin achieves full current sinking capability once the VIN pin is above 2.95V. Figure 21 shows the PWRGD waveform during power-up. The PWRGD pin is pulled low when the voltage on SENSE+ is lower than 91% or greater than 107% of the nominal set voltage. Also, the PWRGD pin is pulled low if the input UVLO or thermal shutdown is asserted, or if the INH pin is pulled low.

8.6 Power-Up Characteristics

When configured as shown in the front page schematic, the LMZ30602 produces a regulated output voltage following the application of a valid input voltage. During the power-up, internal soft-start circuitry slows the rate that the output voltage rises, thereby limiting the amount of in-rush current that can be drawn from the input source. The soft-start circuitry introduces a short time delay from the point that a valid input voltage is recognized. Figure 21 shows the start-up waveforms for a LMZ30602, operating from a 5-V input and with the output voltage adjusted to 1.8 V. The waveform is measured with a 2-A constant current load.

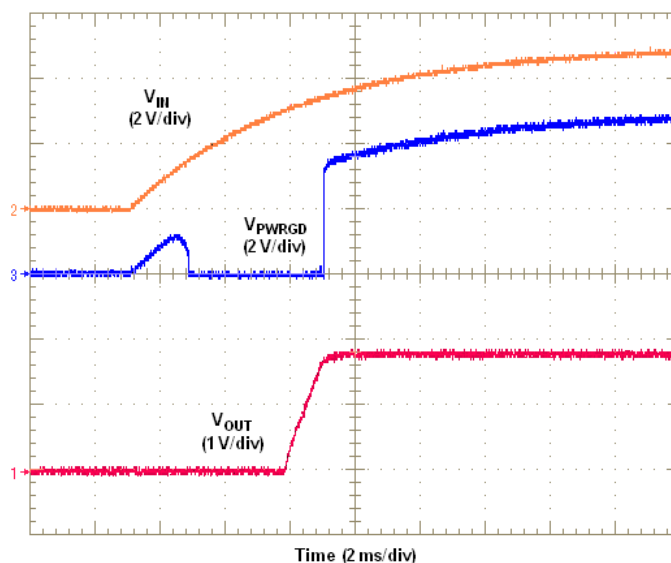


Figure 21. Start-Up Waveforms

8.7 Remote Sense

The SENSE+ pin must be connected to V_{OUT} at the load, or at the device pins.

Connecting the SENSE+ pin to V_{OUT} at the load improves the load regulation performance of the device by allowing it to compensate for any I-R voltage drop between its output pins and the load. An I-R drop is caused by the high output current flowing through the small amount of pin and trace resistance. This should be limited to a maximum of 300 mV.

NOTE

The remote sense feature is not designed to compensate for the forward drop of nonlinear or frequency dependent components that may be placed in series with the converter output. Examples include OR-ing diodes, filter inductors, ferrite beads, and fuses. When these components are enclosed by the SENSE+ connection, they are effectively placed inside the regulation control loop, which can adversely affect the stability of the regulator.

8.8 Output On/Off Inhibit (INH)

The INH pin provides electrical on/off control of the device. Once the INH pin voltage exceeds the threshold voltage, the device starts operation. If the INH pin voltage is pulled below the threshold voltage, the regulator stops switching and enters low quiescent current state.

The INH pin has an internal pull-up current source, allowing the user to float the INH pin for enabling the device. If an application requires controlling the INH pin, use an open drain/collector device, or a suitable logic gate to interface with the pin. Do not place an external pull-up resistor on this pin. Figure 22 shows the typical application of the inhibit function.

Turning Q1 on applies a low voltage to the inhibit control (INH) pin and disables the output of the supply, as shown in Figure 23. If Q1 is turned off, the supply executes a soft-start power-up sequence, as shown in Figure 24. The waveforms were measured with a 2-A constant current load.

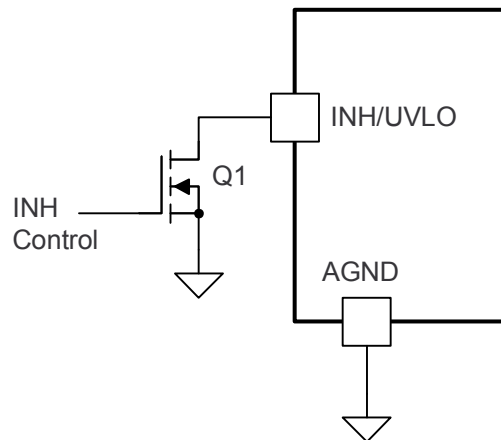
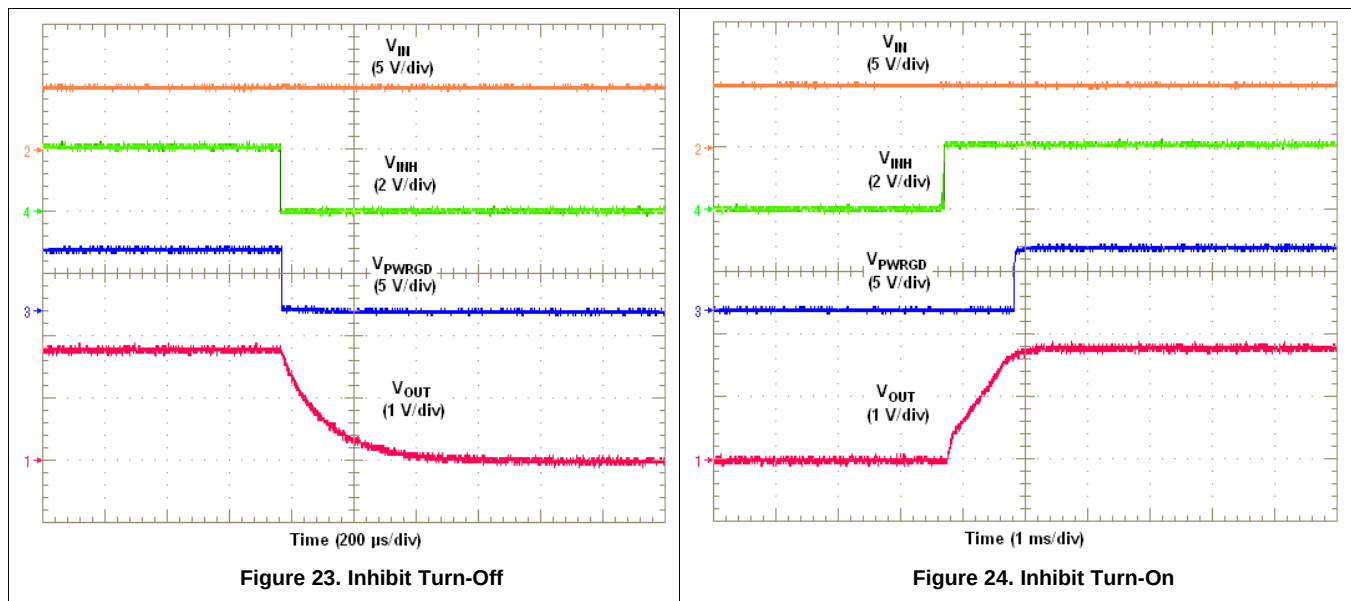


Figure 22. Typical Inhibit Control



8.9 Slow Start (SS/TR)

Connecting the STSEL pin to AGND and leaving SS/TR pin open enables the internal SS capacitor with a slow start interval of approximately 1.1 ms. Adding additional capacitance between the SS pin and AGND increases the slow start time. [Table 8](#) shows an additional SS capacitor connected to the SS/TR pin and the STSEL pin connected to AGND. See [Table 8](#) below for SS capacitor values and timing interval.

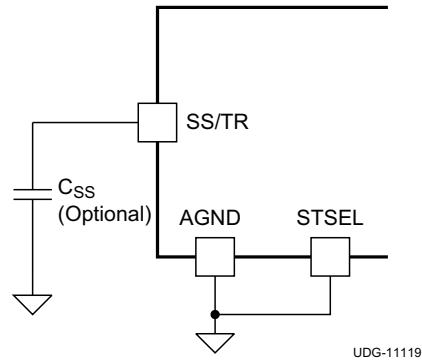


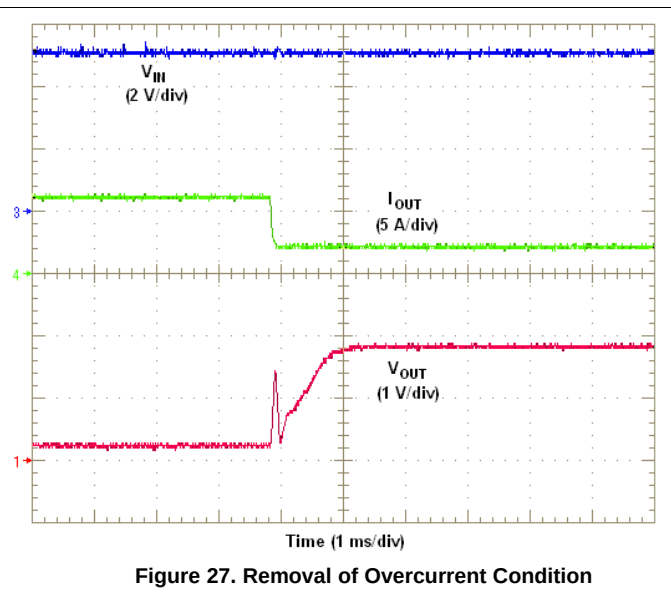
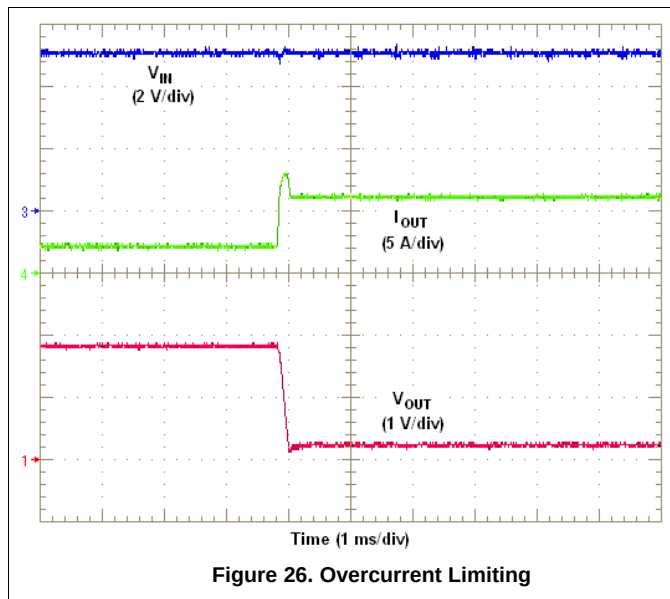
Figure 25. Slow-Start Capacitor (C_{SS}) and STSEL Connection

Table 8. Slow-Start Capacitor Values and Slow-Start Time

C_{SS} (pF)	open	2200	4700	10000	15000	22000	25000
SS Time (msec)	1.1	1.9	2.8	4.6	6.4	8.8	9.8

8.10 Overcurrent Protection

For protection against load faults, the LMZ30602 uses current limiting. The device is protected from overcurrent conditions by cycle-by-cycle current limiting and frequency foldback. During an overcurrent condition the output current is limited and the output voltage is reduced, as shown in [Figure 26](#). When the overcurrent condition is removed, the output voltage returns to the established voltage, as shown in [Figure 27](#).



8.11 Synchronization (CLK)

An internal phase locked loop (PLL) has been implemented to allow synchronization between 500 kHz and 2 MHz, and to easily switch from RT mode to CLK mode. To implement the synchronization feature, connect a square wave clock signal to the RT/CLK pin with a minimum pulse width of 75 ns. The maximum clock pulse width must be calculated using Equation 2. The clock signal amplitude must transition lower than 0.4 V and higher than 2.2 V. The start of the switching cycle is synchronized to the falling edge of RT/CLK pin. In applications where both RT mode and CLK mode are needed, the device can be configured as shown in Figure 28.

Before the external clock is present, the device works in RT mode and the switching frequency is set by RT resistor (R_{RT}). When the external clock is present, the CLK mode overrides the RT mode. The device switches from RT mode to CLK mode and the RT/CLK pin becomes high impedance as the PLL starts to lock onto the frequency of the external clock. The device will lock to the external clock frequency approximately 15 μ s after a valid clock signal is present. It is not recommended to switch from CLK mode back to RT mode because the switching frequency drops to a lower frequency before returning to the switching frequency set by R_{RT} .

$$CLK_PW_{MAX} = \frac{0.75 \times \left(1 - \frac{V_{OUT}}{V_{IN(min)}}\right)}{f_{SW}} \quad (2)$$

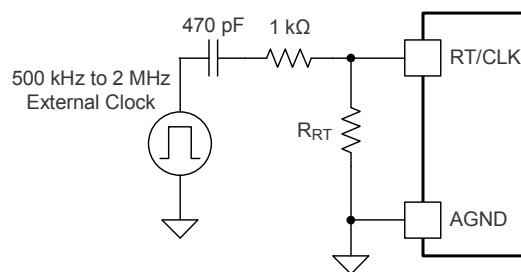


Figure 28. CLK/RT Configuration

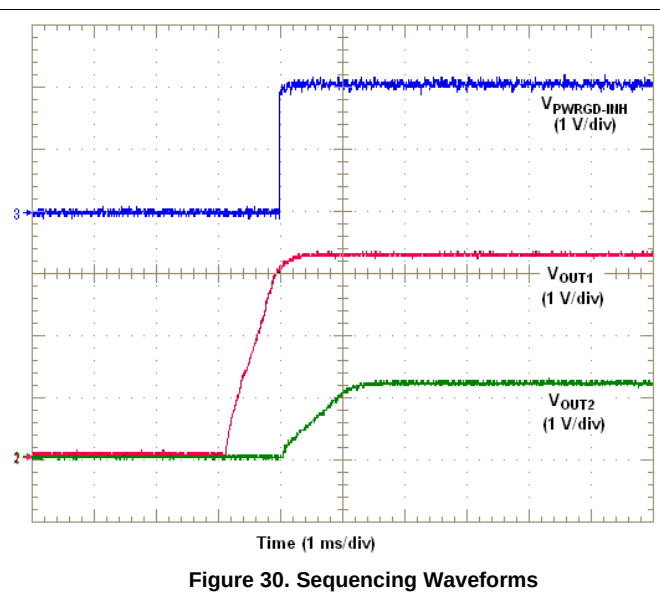
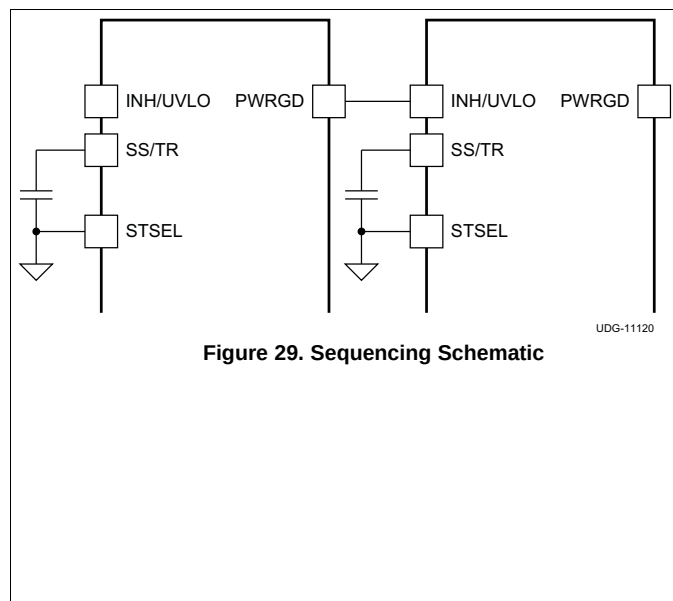
The synchronization frequency must be selected based on the output voltages of the devices being synchronized. Table 9 shows the allowable frequencies for a given range of output voltages based on a resistive load. 5-V input applications requiring 1.5 A or less can synchronize to a wider frequency range. For the most efficient solution, always synchronize to the lowest allowable frequency. For example, an application requires synchronizing three LMZ30602 devices with output voltages of 1.2V@1.7A, 1.8@1.1A and 3.3V@ 1.0A, all powered from $V_{IN} = 5V$. Table 9 shows that all three output voltages can be synchronized to any frequency between 700 kHz to 1 MHz. For best efficiency, choose 700 kHz as the synchronization frequency.

Table 9. Synchronization Frequency vs Output Voltage

SYNCHRONIZATION FREQUENCY (kHz)	R_{RT} (k Ω)	$V_{IN} = 5 V$				$V_{IN} = 3.3 V$	
		$I_{OUT} \leq 1.5 A$		$I_{OUT} > 1.5 A$		All I_{OUT}	
		V_{OUT} RANGE (V)		V_{OUT} RANGE (V)		V_{OUT} RANGE (V)	
		MIN	MAX	MIN	MAX	MIN	MAX
500	open	0.8	1.4	0.8	0.8	0.8	1.1
550	3400	0.8	1.6	0.8	0.9	0.8	1.2
600	1800	0.8	1.9	0.8	1.1	0.8	2.0
650	1200	0.8	2.4	0.8	1.2	0.8	2.2
700	887	0.8	3.6	0.8	1.3	0.8	2.4
750	715	0.9	3.6	0.9	1.5	0.8	2.5
800	590	0.9	3.6	0.9	1.7	0.8	2.5
900	511	1.0	3.6	1.0	2.2	0.8	2.5
1000	348	1.2	3.6	1.2	2.5	0.8	2.5
1250	232	1.4	3.6	1.4	3.3	1.0	2.5
1500	174	1.7	3.6	1.7	3.6	1.1	2.5
1750	137	2.0	3.6	2.0	3.6	1.3	2.4
2000	113	2.3	3.6	2.3	3.6	1.5	2.3

8.12 Sequencing (SS/TR)

Many of the common power supply sequencing methods can be implemented using the SS/TR, INH and PWRGD pins. The sequential method is illustrated in Figure 29 using two LMZ30602 devices. The PWRGD pin of the first device is coupled to the INH pin of the second device which enables the second power supply once the primary supply reaches regulation. Do not place a pull-up resistor on PWRGD in this configuration. Figure 30 shows sequential turn-on waveforms of two LMZ30602 devices.



Simultaneous power supply sequencing can be implemented by connecting the resistor network of R1 and R2 shown in Figure 31 to the output of the power supply that needs to be tracked or to another voltage reference source. Figure 32 shows simultaneous turn-on waveforms of two LMZ30602 devices. Use Equation 3 and Equation 4 to calculate the values of R1 and R2.

$$R1 = \frac{(V_{OUT2} \times 12.6)}{0.803} \text{ (k}\Omega\text{)}$$

(3)

$$R2 = \frac{0.803 \times R1}{(V_{OUT2} - 0.803)} \text{ (k}\Omega\text{)}$$

(4)

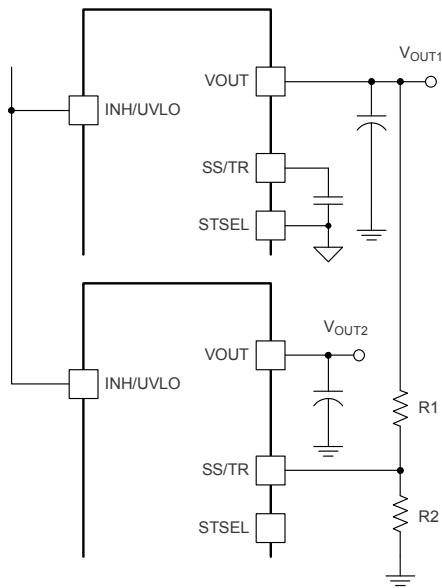


Figure 31. Simultaneous Tracking Schematic

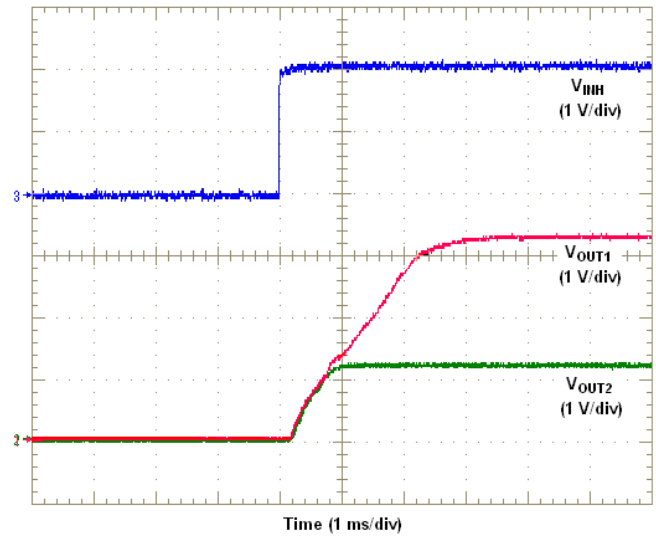


Figure 32. Simultaneous Tracking Waveforms

8.13 Programmable Undervoltage Lockout (UVLO)

The LMZ30602 implements internal UVLO circuitry on the VIN pin. The device is disabled when the VIN pin voltage falls below the internal VIN UVLO threshold. The internal VIN UVLO rising threshold is 3.135 V (max) with a typical hysteresis of 300 mV.

If an application requires a higher UVLO threshold on the VIN pin, the UVLO pin can be configured as shown in [Figure 33](#). [Table 10](#) lists standard values for R_{UVLO} to adjust the VIN UVLO voltage up.

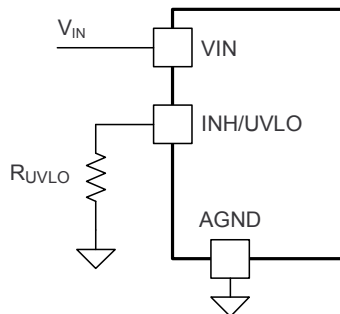


Figure 33. Adjustable VIN UVLO

Table 10. Standard Resistor values for Adjusting VIN UVLO

VIN UVLO (V) (typ)	3.25	3.5	3.75	4.0	4.25	4.5	4.75
R_{UVLO} (k Ω)	294	133	86.6	63.4	49.9	42.2	35.7
Hysteresis (mV)	325	335	345	355	365	375	385

8.14 Thermal Shutdown

The internal thermal shutdown circuitry forces the device to stop switching if the junction temperature exceeds 175°C typically. The device reinitiates the power up sequence when the junction temperature drops below 160°C typically.

8.15 EMI

The LMZ30602 is compliant with EN55022 Class B radiated emissions. [Figure 34](#) and [Figure 35](#) show typical examples of radiated emissions plots for the LMZ30602 operating from 5V and 3.3V respectively. Both graphs include the plots of the antenna in the horizontal and vertical positions.

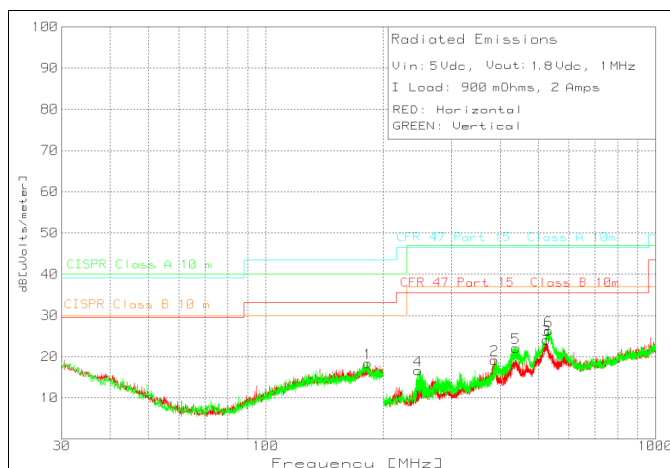


Figure 34. Radiated Emissions 5-V Input, 1.8-V Output, 2-A Load (EN55022 Class B)

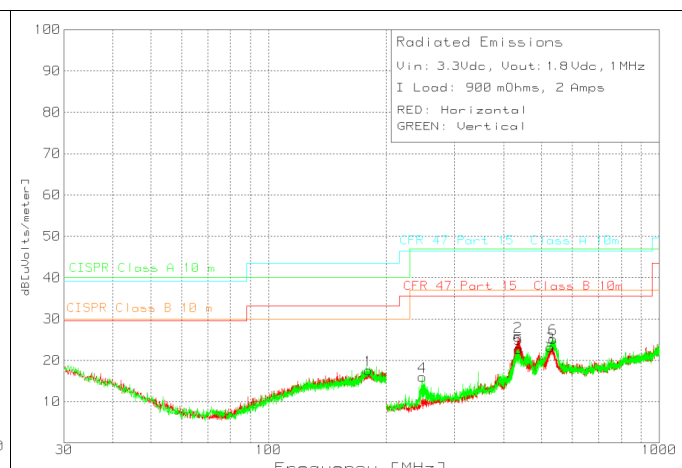


Figure 35. Radiated Emissions 3.3-V Input, 1.8-V Output, 2-A Load (EN55022 Class B)

8.16 Layout Considerations

To achieve optimal electrical and thermal performance, an optimized PCB layout is required. Figure 36, shows a typical PCB layout. Some considerations for an optimized layout are:

- Use large copper areas for power planes (VIN, VOUT, and PGND) to minimize conduction loss and thermal stress.
- Place ceramic input and output capacitors close to the module pins to minimize high frequency noise.
- Locate additional output capacitors between the ceramic capacitor and the load.
- Place a dedicated AGND copper area beneath the LMZ30602.
- Connect the AGND and PGND copper area at one point; directly at the pin 37 PowerPad using multiple vias.
- Place R_{SET} , R_{RT} , and C_{SS} as close as possible to their respective pins.
- Use multiple vias to connect the power planes to internal layers.

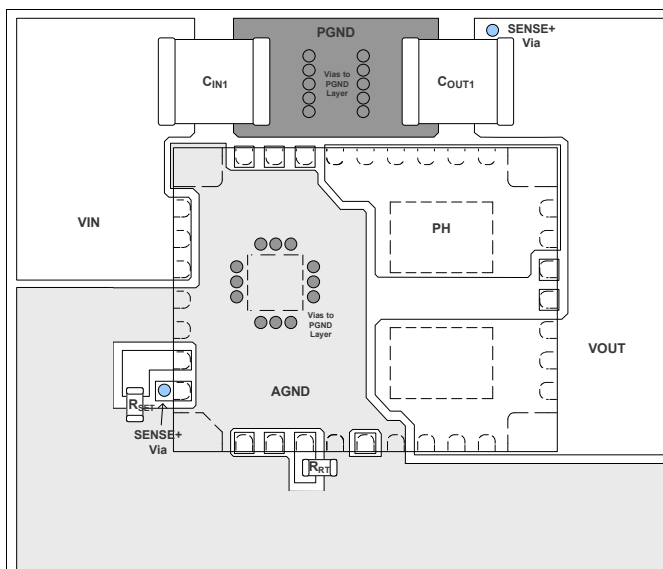


Figure 36. Typical Top-Layer Recommended Layout

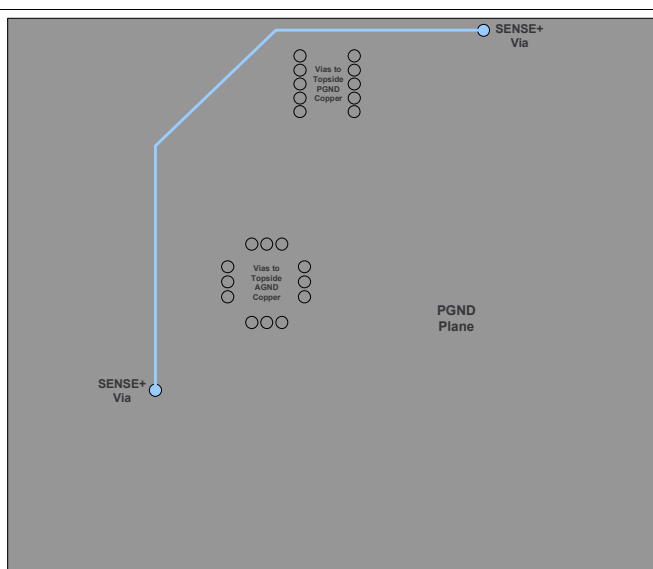


Figure 37. Typical PGND-Layer Recommended Layout

9 Revision History

NOTE: Page numbers for previous revisions may differ from page numbers in the current version.

Changes from Original (July 2013) to Revision A	Page
• Added peak reflow and maximum number of reflows information	2
• Changed voltage levels in Table 9	19

PACKAGING INFORMATION

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan (2)	Lead/Ball Finish (6)	MSL Peak Temp (3)	Op Temp (°C)	Device Marking (4/5)	Samples
LMZ30602RKGR	ACTIVE	B1QFN	RKG	39	500	RoHS Exempt & Green	CU NIPDAU	Level-3-240C-1 YEAR	-40 to 85	(54218, LMZ30602)	Samples
LMZ30602RKGT	ACTIVE	B1QFN	RKG	39	250	RoHS Exempt & Green	CU NIPDAU	Level-3-240C-1 YEAR	-40 to 85	(54218, LMZ30602)	Samples

(1) The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

(2) **RoHS:** TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

RoHS Exempt: TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

Green: TI defines "Green" to mean the content of Chlorine (Cl) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

(3) MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

(4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

(5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

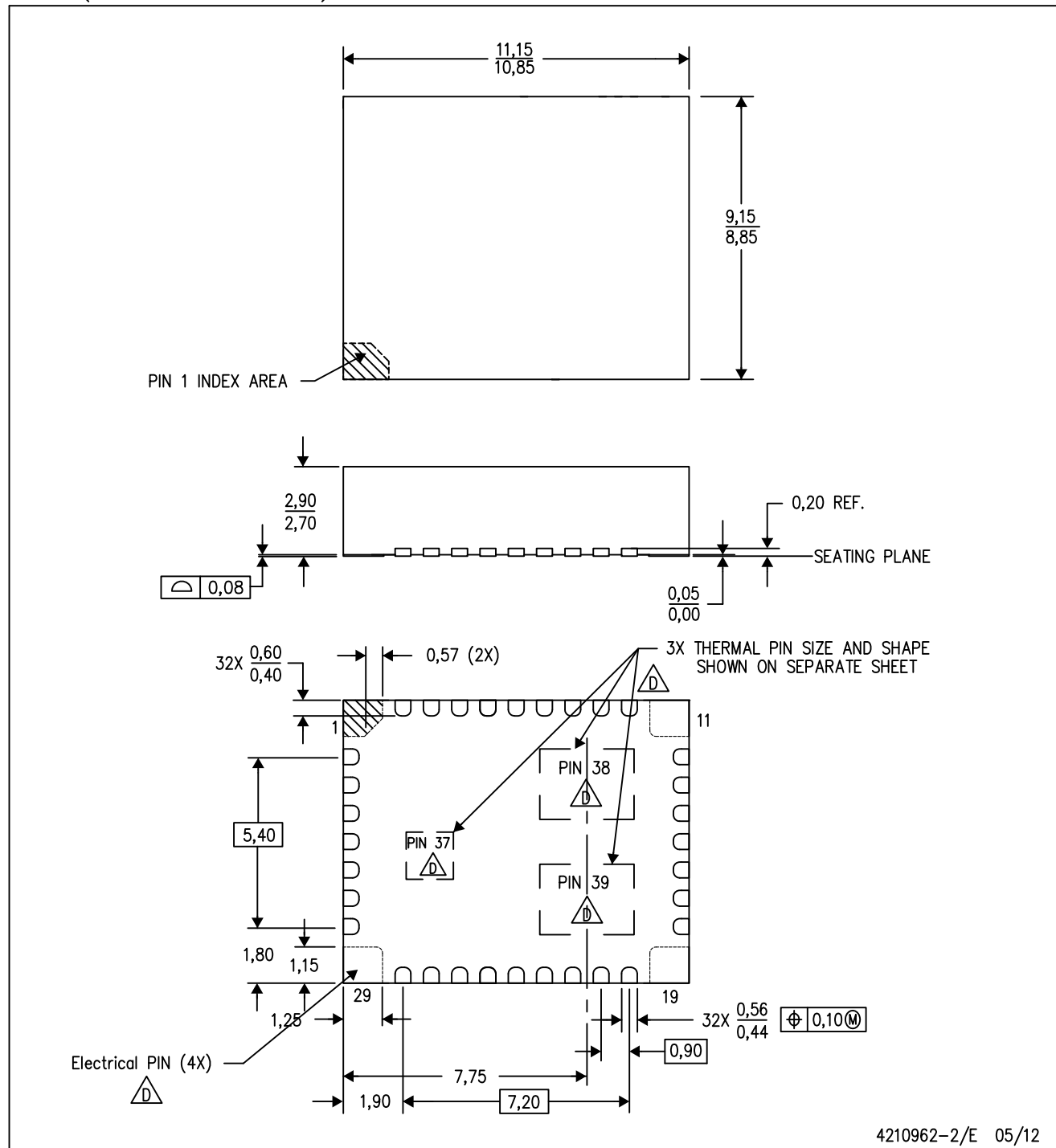
(6) Lead/Ball Finish - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead/Ball Finish values may wrap to two lines if the finish value exceeds the maximum column width.

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In no event shall TI's liability arising out of such information exceed the total purchase price of the TI part(s) at issue in this document sold by TI to Customer on an annual basis.

RKG (R-PB1QFN-N39)

PLASTIC QUAD FLATPACK NO-LEAD



- NOTES:
- A. All linear dimensions are in millimeters. Dimensioning and tolerancing per ASME Y14.5M-1994.
 - B. This drawing is subject to change without notice.
 - C. Quad Flatpack, No-leads (QFN) package configuration.
 - D. The package thermal pad must be soldered to the board for thermal and mechanical performance.
 - E. See the additional figure in the Product Data Sheet for details regarding the exposed thermal pad features and dimensions.
 - F. The package thermal performance may be enhanced by bonding the thermal pad to an external thermal plane.

RKG (R-PQFN-N39)

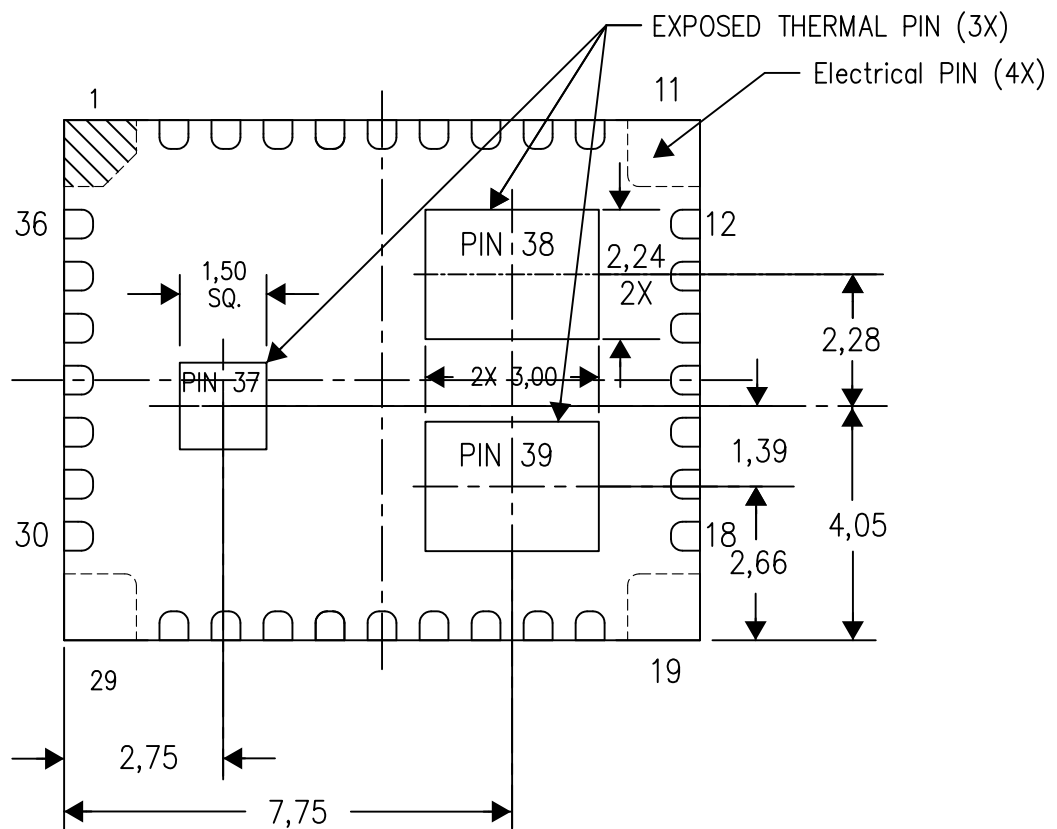
PLASTIC QUAD FLATPACK NO-LEAD

THERMAL INFORMATION

This package incorporates an exposed thermal pad that is designed to be attached directly to an external heatsink. The thermal pad must be soldered directly to the printed circuit board (PCB). After soldering, the PCB can be used as a heatsink. In addition, through the use of thermal vias, the thermal pad can be attached directly to the appropriate copper plane shown in the electrical schematic for the device, or alternatively, can be attached to a special heatsink structure designed into the PCB. This design optimizes the heat transfer from the integrated circuit (IC).

For information on the Quad Flatpack No-Lead (QFN) package and its advantages, refer to Application Report, QFN/SON PCB Attachment, Texas Instruments Literature No. SLUA271. This document is available at www.ti.com.

The exposed thermal pad dimensions for this package are shown in the following illustration.



Bottom View

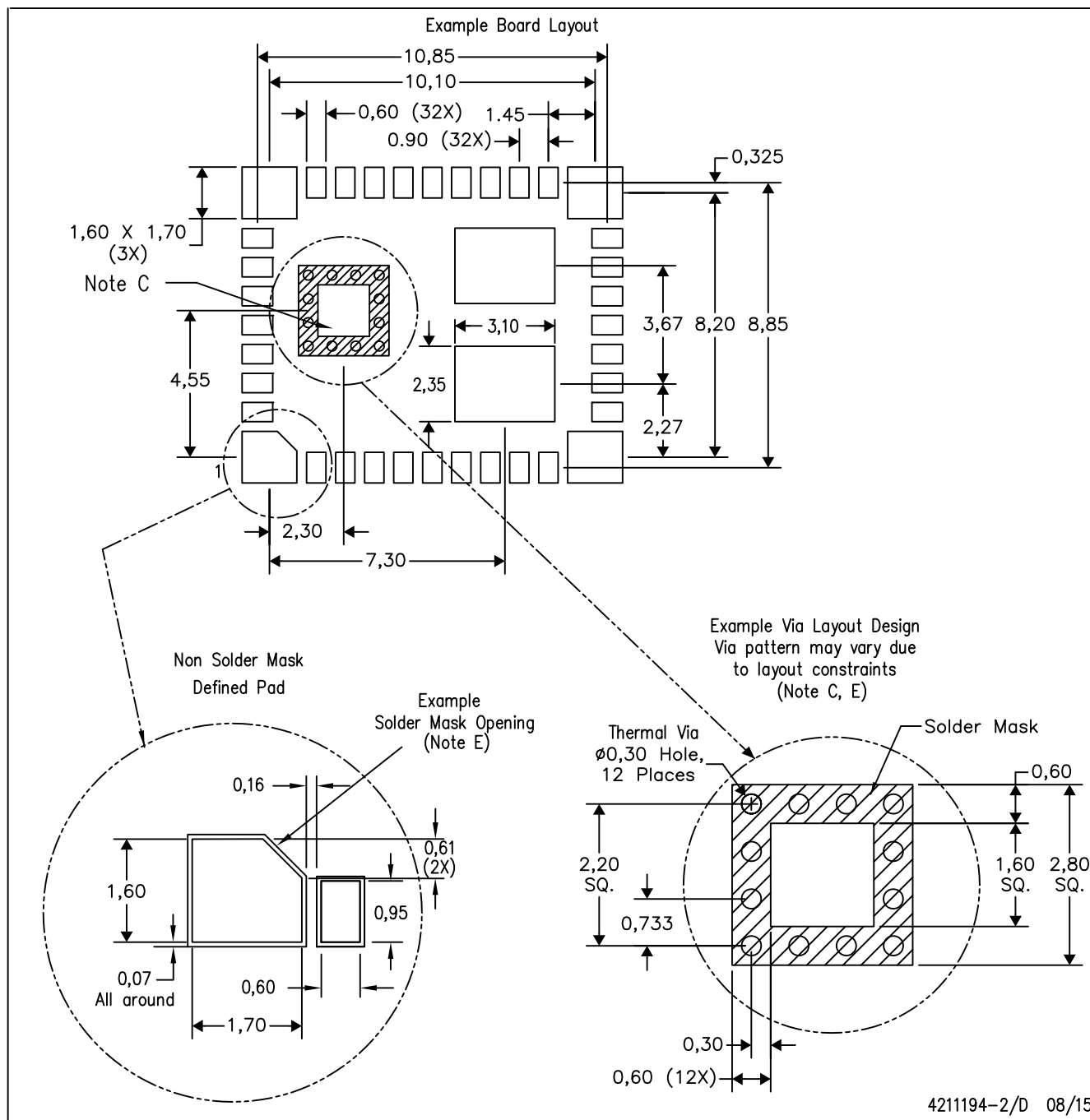
Exposed Thermal Pad Dimensions
Thermal Pad Tolerance: $\pm 0.10\text{mm}$

4211170-2/D 01/15

NOTE: A. All linear dimensions are in millimeters

RKG (S-PB1QFN-N39)

PLASTIC QUAD FLATPACK NO-LEAD

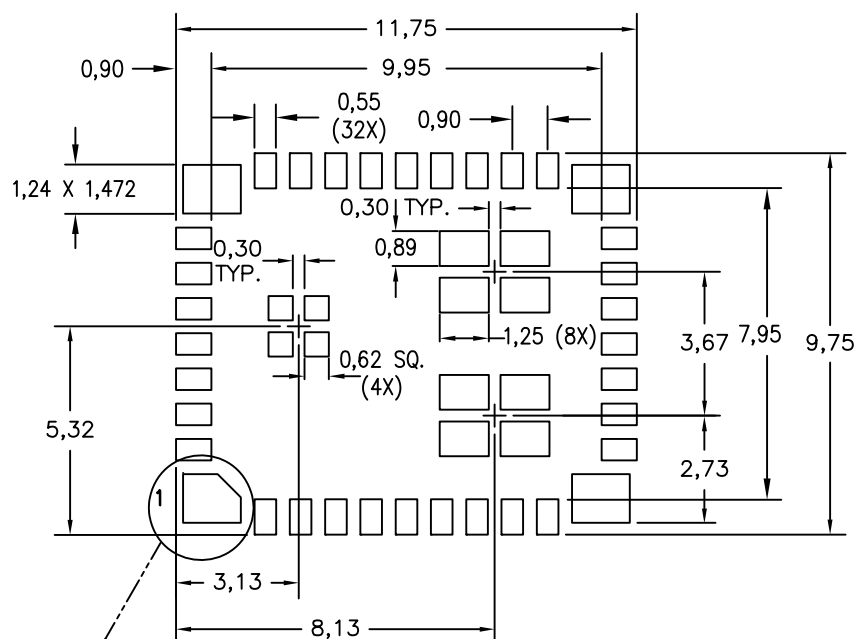


- NOTES:
- A. All linear dimensions are in millimeters.
 - B. This drawing is subject to change without notice.
 - C. This package is designed to be soldered to a thermal pad on the board. Refer to Application Note, Quad Flat-Pack Packages, Texas Instruments Literature No. SLUA271, and also the Product Data Sheets for specific thermal information, via requirements, and recommended board layout. These documents are available at www.ti.com <<http://www.ti.com>>.
 - D. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC 7525 for stencil design considerations.
 - E. Customers should contact their board fabrication site for minimum solder mask web tolerances between signal pads.

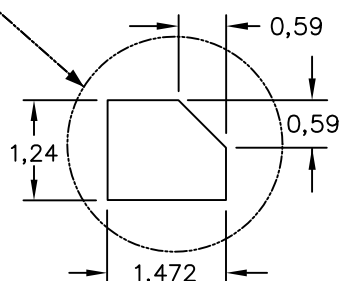
RKG (S-PB1QFN-N39)

PLASTIC QUAD FLATPACK NO-LEAD

Example Stencil Design (Note D)
Stencil Thickness = 0,125mm



60% solder coverage on thermal pads



4211194-3/D 08/15

- NOTES:
- A. All linear dimensions are in millimeters.
 - B. This drawing is subject to change without notice.
 - C. This package is designed to be soldered to a thermal pad on the board. Refer to Application Note, Quad Flat-Pack Packages, Texas Instruments Literature No. SLUA271, and also the Product Data Sheets for specific thermal information, via requirements, and recommended board layout. These documents are available at www.ti.com <<http://www.ti.com>>.
 - D. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC 7525 for stencil design considerations.
 - E. Customers should contact their board fabrication site for minimum solder mask web tolerances between signal pads.

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